Power MOSFET

60 V, 0.81 m Ω , 398.2 A, Single N-Channel

Features

- Small Footprint (8x8 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- Power 88 Package, Industry Standard
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage	Э		V_{GS}	±20	V
Continuous Drain	$T_C = 25^{\circ}C$		I _D	398.2	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		281.6	
Power Dissipation	State	T _C = 25°C	P_{D}	244	W
R _{θJC} (Note 1)		T _C = 100°C		122	
Continuous Drain Current R _{0.IA}		T _A = 25°C	I _D	56.9	Α
(Notes 1, 2, 3)	Steady	T _A = 100°C		40.2	
Power Dissipation	State	T _A = 25°C	P_{D}	5.0	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		2.5	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	900	Α
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	203.4	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 30 A)			E _{AS}	887	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	0.614	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	30.1	

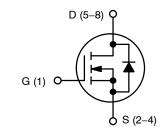
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



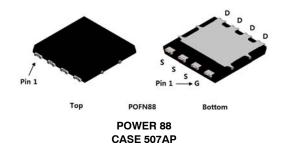
ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
60 V	0.81 mΩ @ 10 V	000 0 4	
	1.05 mΩ @ 4.5 V	398.2 A	



N-CHANNEL MOSFET



MARKING DIAGRAM



XXX = Device Code

(8 A-N characters max) = Assembly Location

WL = 2-digit Wafer Lot Code

Y = Year Code

WW = Work Week Code

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				-		•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref to 25°C			25		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			10	
		V _{DS} = 60 V	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	s = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.2		2.2	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 250 μA, ref	f to 25°C		-5.53		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 50 A		0.73	0.81	mΩ
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 50 A		0.94	1.05	mΩ
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I _D	= 50 A		275		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			12300		
Output Capacitance	Coss				6225		pF
Reverse Transfer Capacitance	C _{RSS}				130		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 30 V; I _D = 50 A			165		nC
Total Gate Charge	Q _{G(TOT)}				74.3		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V}; I_D = 50 \text{ A}$			15.6		
Gate-to-Source Charge	Q_GS				28.7		nC
Gate-to-Drain Charge	Q_GD				14.7		
Plateau Voltage	V_{GP}				2.59		V
SWITCHING CHARACTERISTICS (Note 5	5)						
Turn-On Delay Time	t _{d(ON)}				47.2		
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS}$	s = 30 V,		25.2		- ns
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 50 \text{ A}, R_G = 100 \text{ A}$	= 2.5 Ω		70.7		
Fall Time	t _f				23.3		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V},$ $I_{S} = 50 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.77	1.2	
					0.63		·
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			98.9		
Charge Time	t _a				66.8		ns
Discharge Time	t _b				32.1		1
Reverse Recovery Charge	Q_RR				229		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

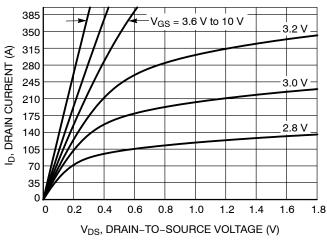


Figure 1. On-Region Characteristics

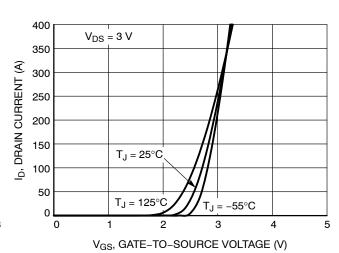


Figure 2. Transfer Characteristics

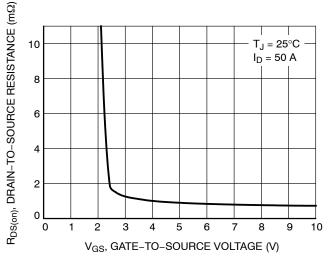


Figure 3. On-Resistance vs. Gate-to-Source Voltage

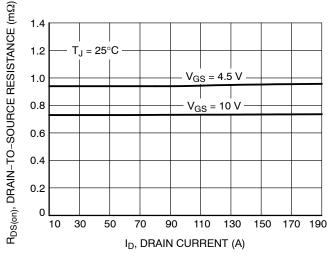


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

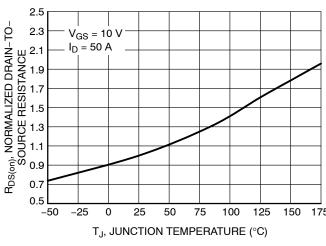


Figure 5. On–Resistance Variation with Temperature

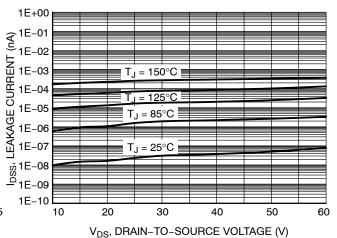


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

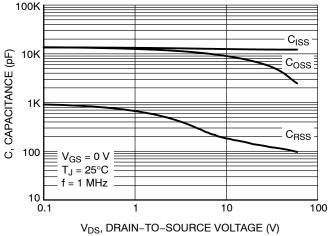


Figure 7. Capacitance Variation

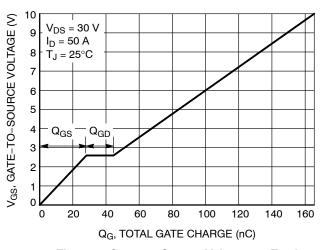


Figure 8. Gate-to-Source Voltage vs. Total Charge

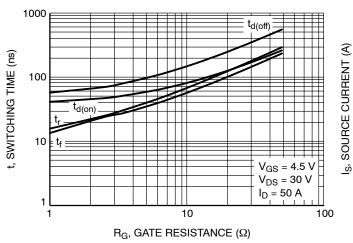


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

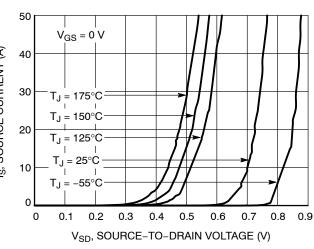


Figure 10. Diode Forward Voltage vs. Current

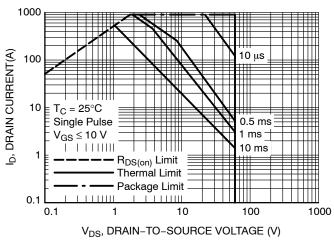


Figure 11. Maximum Rated Forward Biased Safe Operating Area

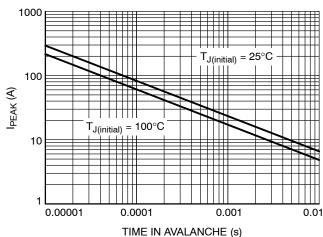


Figure 12. $I_{\mbox{\scriptsize PEAK}}$ vs. Time in Avalanche

TYPICAL CHARACTERISTICS

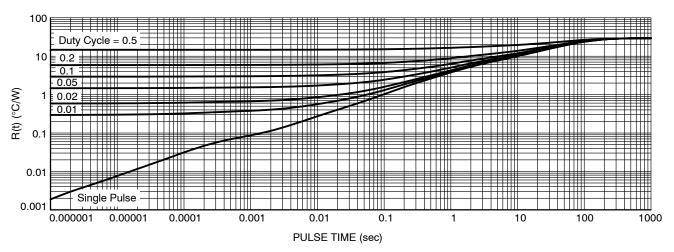
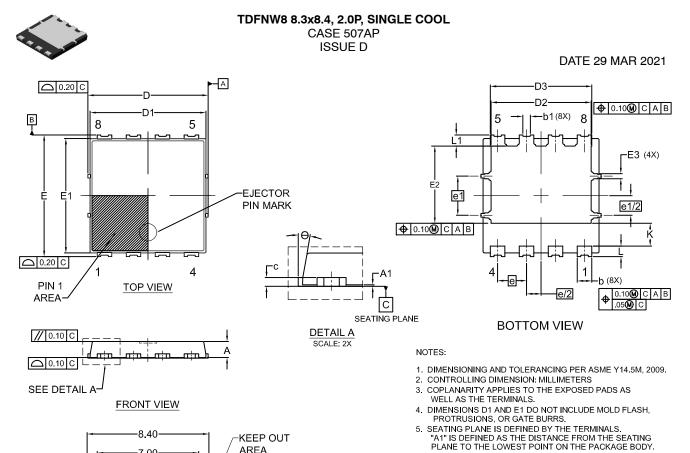


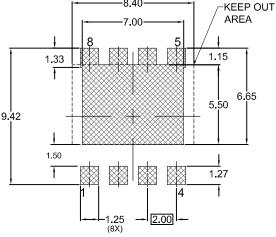
Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTMTS001N06CLTXG	001N06CL	POWER 88 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

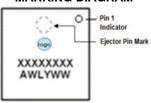




RECOMMENDED LAND PATTERN*

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
WL = Wafer Lot Code
Y = Year Code
WW = Work Week Code

^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS			
DIW	MIN.	MAX.		
Α	1.00	1.10	1.20	
A1	0.00	-	0.05	
b	0.90	1.00	1.10	
b1	0.35	0.45	0.55	
C	0.23	0.28	0.33	
О	8.20	8.30	8.40	
D1	7.90	8.00	8.10	
D2	6.80	6.90	7.00	
D3	6.90	7.00	7.10	
Е	8.30	8.40	8.50	
E1	7.80	7.90	8.00	
E2	5.24	5.34	5.44	
E3	0.25	0.35	0.45	
е		2.00 BS	С	
e/2	1.00 BSC			
e1	2.70 BSC			
e1/2	1.35 BSC			
K	1.50	1.57	1.70	
L	0.64	0.74	0.84	
L1	0.67	0.77	0.87	
Ф	0°		12°	

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